

MOSFET

OptiMOS[™] 5 Power-MOSFET, 25 V

Features

- Optimized for high performance buck converters Monolithic integrated Schottky like diode Very low on-resistance $R_{\rm DS(on)}$ @ $V_{\rm GS}$ =4.5 V 100% avalanche tested

- N-channel
- Qualified according to JEDEC¹⁾ for target applications
 Pb-free lead plating; RoHS compliant
 Halogen-free according to IEC61249-2-21



Parameter	Value	Unit	
V _{DS}	25	V	
R _{DS(on),max}	0.95	mΩ	
I _D	217	Α	
Q _{OSS}	27	nC	
Q _G (0V4.5V)	17	nC	











Type / Ordering Code	Package	Marking	Related Links
BSC009NE2LS5I	PG-TDSON-8	09NE2L5I	-

OptiMOSTM 5 Power-MOSFET, 25 V BSC009NE2LS5I



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1 Maximum ratings at T_A =25 °C, unless otherwise specified

Table 2 **Maximum ratings**

Danamatan	Ols al	Values				
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Continuous drain current ¹⁾	I _D	- - - -	- - - -	217 137 182 115 40	A	$V_{\rm GS}$ =10 V, $T_{\rm C}$ =25 °C $V_{\rm GS}$ =10 V, $T_{\rm C}$ =100 °C $V_{\rm GS}$ =4.5 V, $T_{\rm C}$ =25 °C $V_{\rm GS}$ =4.5 V, $T_{\rm C}$ =100 °C $V_{\rm GS}$ =10 V, $T_{\rm A}$ =25 °C, $R_{\rm thJA}$ =50 K/W ²⁾
Pulsed drain current ³⁾	I _{D,pulse}	-	-	868	Α	<i>T</i> _C =25 °C
Avalanche current, single pulse ⁴⁾	I _{AS}	-	-	50	Α	<i>T</i> _C =25 °C
Avalanche energy, single pulse	E AS	-	-	50	mJ	$I_{\rm D}$ =50 A, $R_{\rm GS}$ =25 Ω
Gate source voltage	V _{GS}	-16	-	16	V	-
Power dissipation	P _{tot}	-	-	74 2.5	W	T _C =25 °C T _A =25 °C, R _{thJA} =50 K/W ²⁾
Operating and storage temperature	T _j , T _{stg}	-55	-	150	°C	IEC climatic category; DIN IEC 68-1: 55/150/56

2 Thermal characteristics

Table 3 Thermal characteristics

Davamatav	Cumbal	Values			I I m i 4	Nata / Tast Candition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Thermal resistance, junction - case	R _{thJC}	-	-	1.7	K/W	-
Thermal resistance, junction - case, top	R _{thJC}	-	-	20	K/W	-
Device on PCB, 6 cm ² cooling area ²⁾	R _{thJA}	_	_	50	K/W	-

¹⁾ Rating refers to the product only with datasheet specified absolute maximum values, maintaining case temperature at 25°C. For higher case temperature please refer to Diagram 2. De-rating will be required based on the actual environmental conditions.

2) Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm2 (one layer, 70 µm thick) copper area for drain

connection. PCB is vertical in still air.

3) See Diagram 3 for more detailed information

4) See Diagram 13 for more detailed information

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3 Electrical characteristics at T_j =25 °C, unless otherwise specified

Table 4 **Static characteristics**

Parameter	0hl	Values			1114	Nata / Tank Oam distant
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	V _{(BR)DSS}	25	-	-	V	V _{GS} =0 V, I _D =1 mA
Breakdown voltage temperature coefficient	$dV_{(BR)DSS}/dT_{j}$	-	15	-	mV/K	I _D =10 mA, referenced to 25 °C
Gate threshold voltage	V _{GS(th)}	1.2	1.6	2	V	V _{DS} =V _{GS} , I _D =250 μA
Zero gate voltage drain current	l _{DSS}		- 3	0.5	mA	V _{DS} =20 V, V _{GS} =0 V, T _j =25 °C V _{DS} =20 V, V _{GS} =0 V, T _j =125 °C
Gate-source leakage current	I _{GSS}	-	10	100	nA	V _{GS} =20 V, V _{DS} =0 V
Drain-source on-state resistance	R _{DS(on)}	-	1.05 0.80	1.35 0.95	mΩ	V _{GS} =4.5 V, I _D =30 A V _{GS} =10 V, I _D =30 A
Gate resistance	R _G	-	1.1	1.8	Ω	-
Transconductance	G fs	75	150	-	S	V _{DS} >2 I _D R _{DS(on)max} , I _D =30 A

Table 5 **Dynamic characteristics**

Developed	Symbol	Values				
Parameter		Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance ¹⁾	Ciss	-	2400	3200	pF	V _{GS} =0 V, V _{DS} =12 V, <i>f</i> =1 MHz
Output capacitance ¹⁾	Coss	-	1400	1900	pF	V _{GS} =0 V, V _{DS} =12 V, <i>f</i> =1 MHz
Reverse transfer capacitance	C _{rss}	-	130	-	pF	V _{GS} =0 V, V _{DS} =12 V, <i>f</i> =1 MHz
Turn-on delay time	t _{d(on)}	-	5	-	ns	$V_{\rm DD}$ =12 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =30 A, $R_{\rm G,ext}$ =1.6 Ω
Rise time	t _r	-	5	-	ns	$V_{\rm DD}$ =12 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =30 A, $R_{\rm G,ext}$ =1.6 Ω
Turn-off delay time	$t_{\sf d(off)}$	-	27	-	ns	$V_{\rm DD}$ =12 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =30 A, $R_{\rm G,ext}$ =1.6 Ω
Fall time	t _f	-	4	-	ns	$V_{\rm DD}$ =12 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =30 A, $R_{\rm G,ext}$ =1.6 Ω

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Table 6 Gate charge characteristics¹⁾

Parameter	Cymphal	Values			11	Nata / Tank Oan I'll an
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	Q _{gs}	-	5.7	-	nC	V_{DD} =12 V, I_{D} =30 A, V_{GS} =0 to 4.5 V
Gate charge at threshold	Q _{g(th)}	-	3.9	-	nC	V_{DD} =12 V, I_{D} =30 A, V_{GS} =0 to 4.5 V
Gate to drain charge	Q _{gd}	-	4.3	-	nC	V _{DD} =12 V, I _D =30 A, V _{GS} =0 to 4.5 V
Switching charge	Q _{sw}	-	6.1	-	nC	V _{DD} =12 V, I _D =30 A, V _{GS} =0 to 4.5 V
Gate charge total ²⁾	Q_{g}	-	17	23	nC	V _{DD} =12 V, I _D =30 A, V _{GS} =0 to 4.5 V
Gate plateau voltage	V _{plateau}	-	2.3	-	V	V_{DD} =12 V, I_{D} =30 A, V_{GS} =0 to 4.5 V
Gate charge total ²⁾	Q_{g}	-	36	49	nC	V _{DD} =12 V, I _D =30 A, V _{GS} =0 to 10 V
Gate charge total, sync. FET	Q _{g(sync)}	-	15	-	nC	V _{DS} =0.1 V, V _{GS} =0 to 4.5 V
Output charge	Qoss	-	27	-	nC	V _{DD} =12 V, V _{GS} =0 V

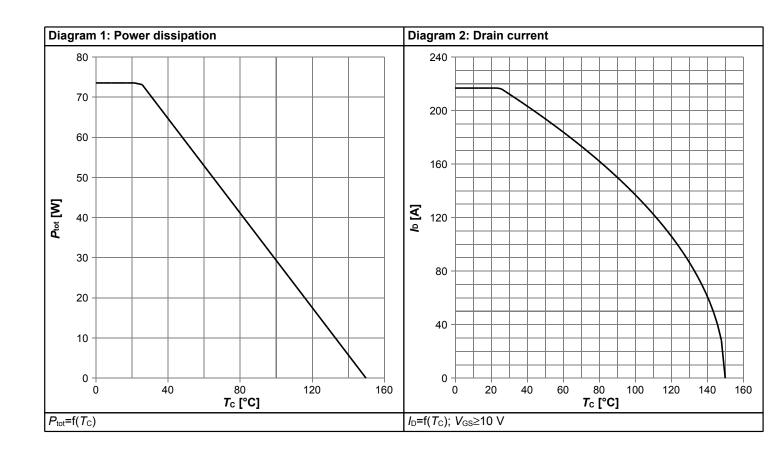
Table 7 Reverse diode

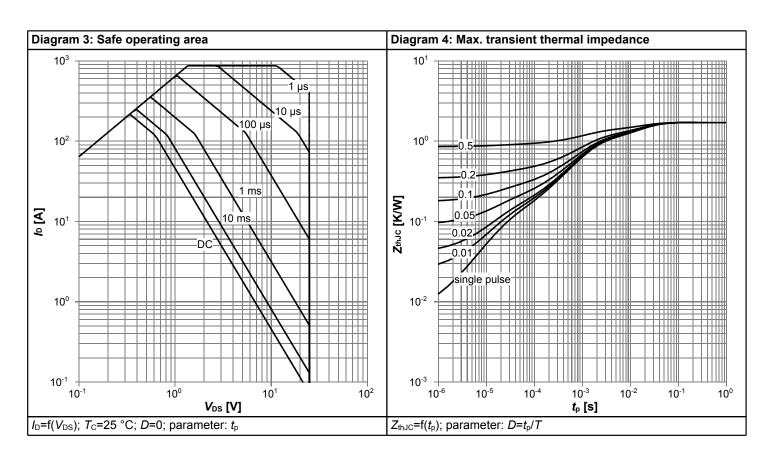
Parameter	Cymphol		Values			Note / Took Condition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Diode continuous forward current	Is	-	-	74	Α	T _C =25 °C
Diode pulse current	I _{S,pulse}	-	-	868	Α	<i>T</i> _C =25 °C
Diode forward voltage	V _{SD}	-	0.48	0.62	V	V _{GS} =0 V, I _F =11 A, T _j =25 °C
Reverse recovery charge	Qrr	-	5	-	nC	V _R =15 V, I _F =12 A, d <i>i</i> _F /d <i>t</i> =400 A/μs

 $^{^{1)}}$ See "Gate charge waveforms" for parameter definition $^{2)}$ Defined by design. Not subject to production test

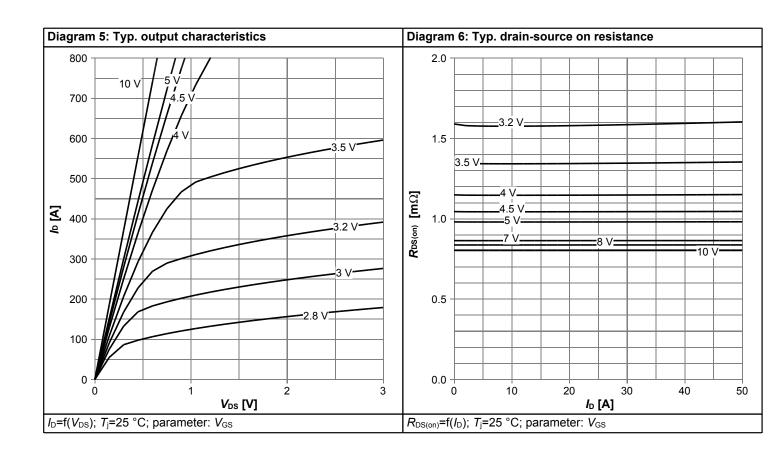


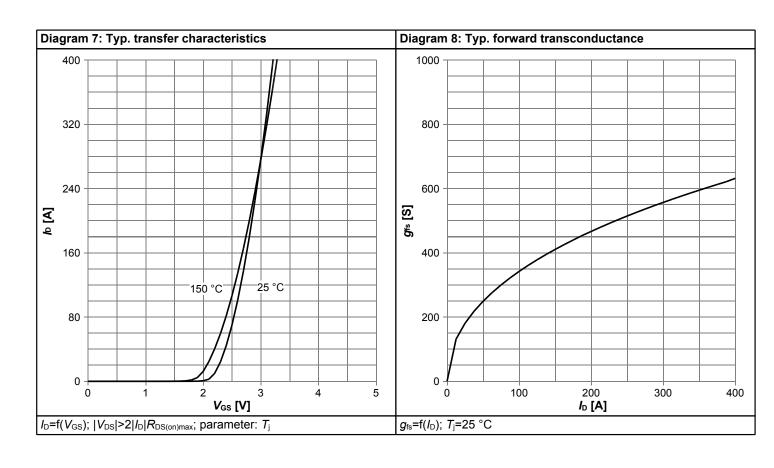
4 Electrical characteristics diagrams



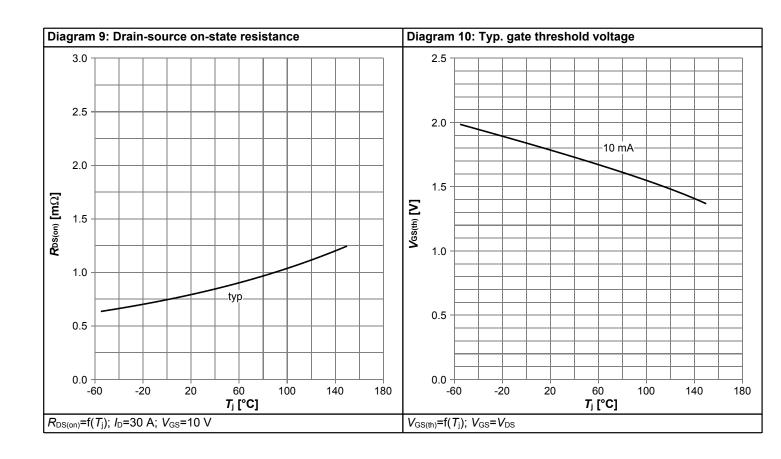


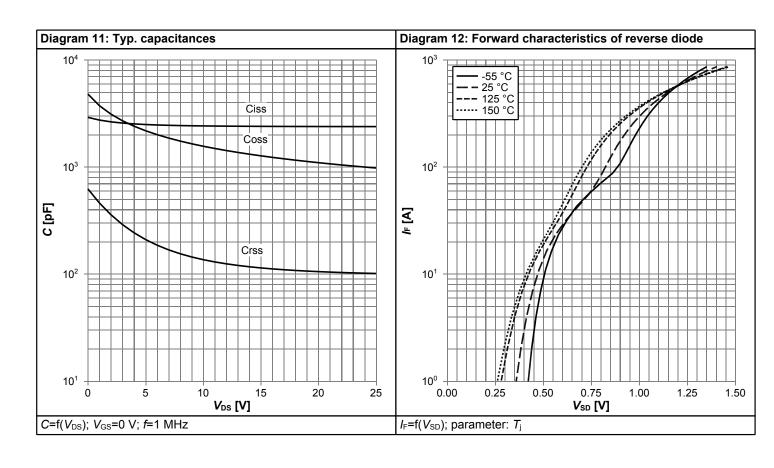




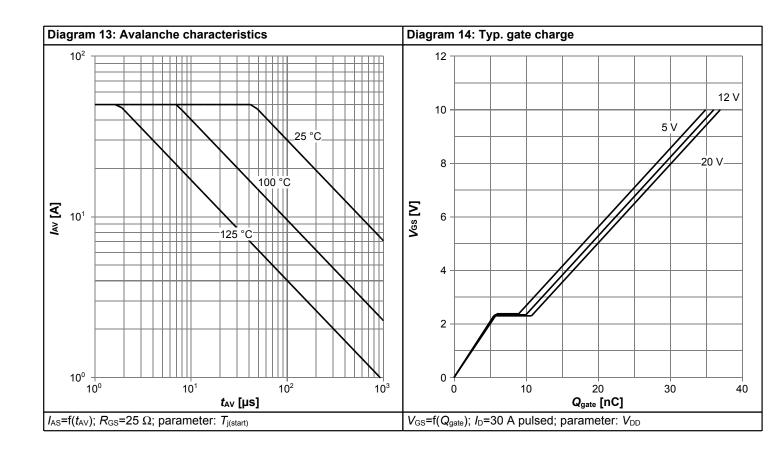


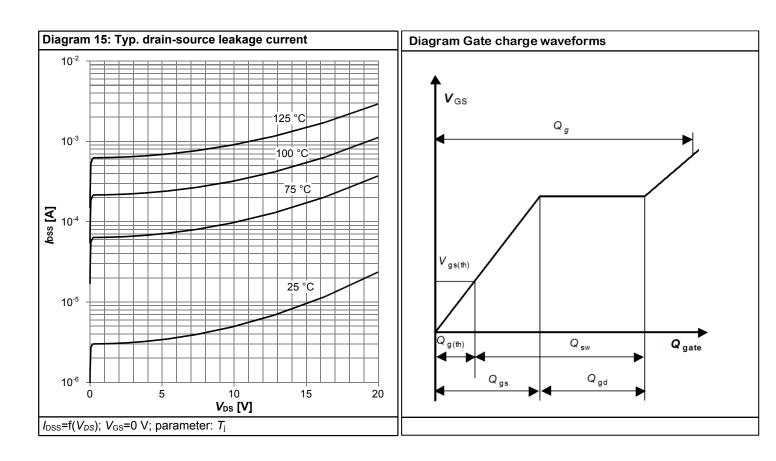






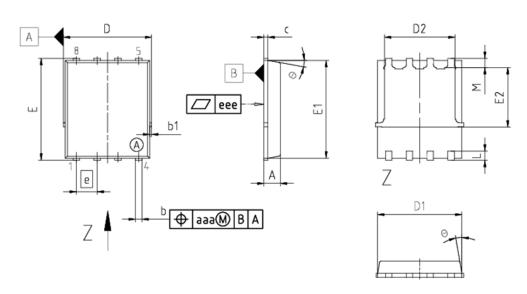








5 Package Outlines



DIM	MILLIM	ETERS				
DIM	MIN	MAX				
Α	0.90	1.10				
b	0.31	0.54				
b1	0.02	0.22				
С	0.15	0.35				
D	5.15	5.49				
D1	4.95	5.35				
D2	3.70	4.40				
E	5.95	6.35				
E1	5.70	6.10				
E2	3.40 3.80					
e	1.27					
N	8					
L	0.45 0.71					
М	0.45 0.75					
Θ	8.5° 12°					
aaa	0.25					
eee	0.08					

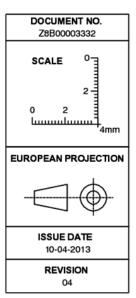
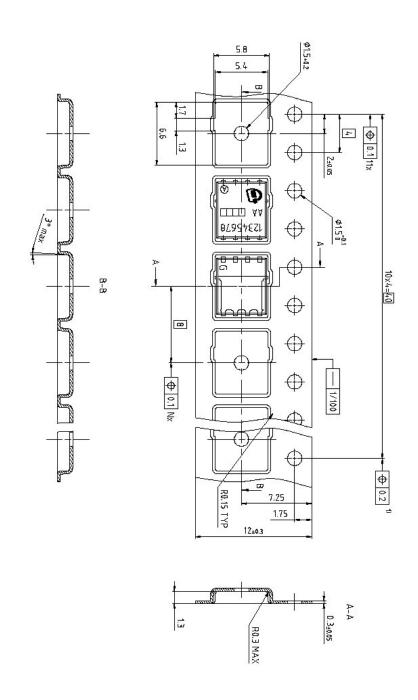


Figure 1 Outline PG-TDSON-8, dimensions in mm





Dimension in mm

Figure 2 Outline Tape (TDSON-8)

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Revision History

BSC009NE2LS5I

Revision: 2020-06-17, Rev. 2.1

Previous Revision

1 10110001	Torrodo Novicion						
Revision	sion Date Subjects (major changes since last revision)						
2.0	2015-03-10	Release of final version					
2.1	2020-06-17	Update current rating and footnotes					

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